


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/532,155		VANDERPERREN ET AL.	
	Examiner		Art Unit	
	NAHEED EJAZ		2611	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375		326								
INTERNATIONAL CLASSIFICATION										
H	0	4	L	27/00						
				/						
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Naheed Ejaz (03/28/2008) (Assistant Examiner) (Date)					/Chieh M. Fan/ 3/28/08 (Part of Primary Examiner) (Date)					Total Claims Allowed: 24 O.G. Print Claim(s) 1
(Part of Legal Instruments Examiner) (Date)										O.G. Print Fig. 3

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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